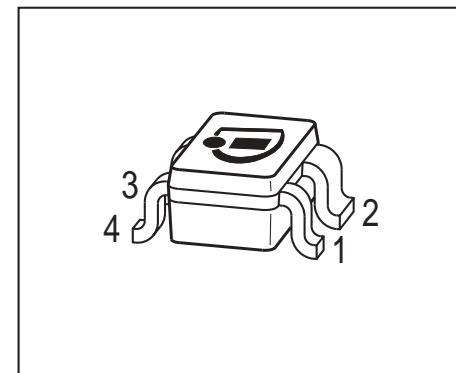


**NPN Silicon RF Transistor\***

- For ESD protected high gain low noise amplifier
- Excellent ESD performance  
typical value 1000 V (HBM)
- Outstanding  $G_{ms} = 21.5$  dB  
Noise Figure  $F = 0.9$  dB
- Gold metallization for high reliability
- SIEGET® 45 - Line
- Pb-free (RoHS compliant) package<sup>1)</sup>
- Qualified according AEC Q101

\* Short term description



**ESD (Electrostatic discharge) sensitive device, observe handling precaution!**

Type	Marking	Pin Configuration						Package
BFP540ESD	AUs	1=B	2=E	3=C	4=E	-	-	SOT343

**Maximum Ratings**

Parameter	Symbol	Value	Unit
Collector-emitter voltage $T_A > 0^\circ\text{C}$	$V_{CEO}$	4.5	V
$T_A \leq 0^\circ\text{C}$		4	
Collector-emitter voltage	$V_{CES}$	10	
Collector-base voltage	$V_{CBO}$	10	
Emitter-base voltage	$V_{EBO}$	1	
Collector current	$I_C$	80	mA
Base current	$I_B$	8	
Total power dissipation <sup>2)</sup> $T_S \leq 77^\circ\text{C}$	$P_{tot}$	250	mW
Junction temperature	$T_j$	150	°C
Ambient temperature	$T_A$	-65 ... 150	
Storage temperature	$T_{stg}$	-65 ... 150	

<sup>1</sup>Pb-containing package may be available upon special request

<sup>2</sup> $T_S$  is measured on the collector lead at the soldering point to the pcb

**Thermal Resistance**

Parameter	Symbol	Value	Unit
Junction - soldering point <sup>1)</sup>	$R_{thJS}$	$\leq 290$	K/W

**Electrical Characteristics** at  $T_A = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

**DC Characteristics**

Collector-emitter breakdown voltage $I_C = 1 \text{ mA}, I_B = 0$	$V_{(\text{BR})\text{CEO}}$	4.5	5	-	V
Collector-emitter cutoff current $V_{CE} = 10 \text{ V}, V_{BE} = 0$	$I_{CES}$	-	-	10	$\mu\text{A}$
Collector-base cutoff current $V_{CB} = 5 \text{ V}, I_E = 0$	$I_{CBO}$	-	-	100	nA
Emitter-base cutoff current $V_{EB} = 0.5 \text{ V}, I_C = 0$	$I_{EBO}$	-	-	10	$\mu\text{A}$
DC current gain $I_C = 20 \text{ mA}, V_{CE} = 3.5 \text{ V}, \text{pulse measured}$	$h_{FE}$	50	110	170	-

<sup>1)</sup>For calculation of  $R_{thJA}$  please refer to Application Note Thermal Resistance

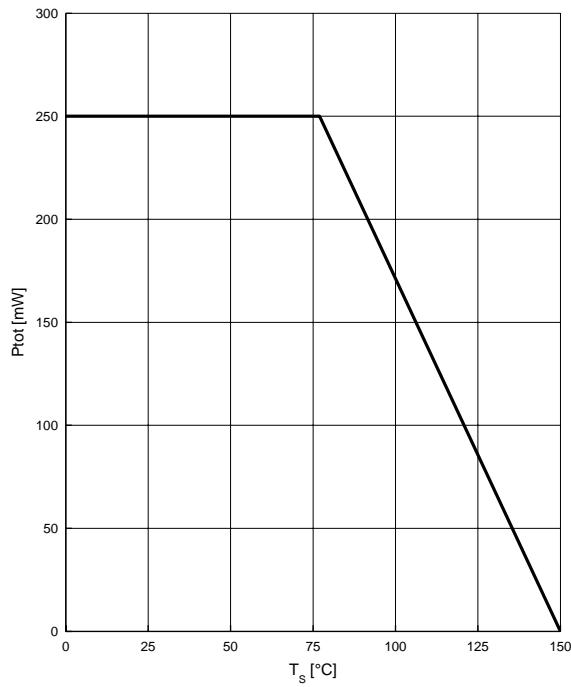
**Electrical Characteristics** at  $T_A = 25^\circ\text{C}$ , unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
<b>AC Characteristics</b> (verified by random sampling)					
Transition frequency $I_C = 50 \text{ mA}, V_{CE} = 4 \text{ V}, f = 1 \text{ GHz}$	$f_T$	21	30	-	GHz
Collector-base capacitance $V_{CB} = 2 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0 \text{ , emitter grounded}$	$C_{cb}$	-	0.14	0.24	pF
Collector emitter capacitance $V_{CE} = 2 \text{ V}, f = 1 \text{ MHz}, V_{BE} = 0 \text{ , base grounded}$	$C_{ce}$	-	0.41	-	
Emitter-base capacitance $V_{EB} = 0.5 \text{ V}, f = 1 \text{ MHz}, V_{CB} = 0 \text{ , collector grounded}$	$C_{eb}$	-	0.59	-	
Noise figure $I_C = 5 \text{ mA}, V_{CE} = 2 \text{ V}, f = 1.8 \text{ GHz}, Z_S = Z_{\text{Sopt}}$ $I_C = 5 \text{ mA}, V_{CE} = 2 \text{ V}, f = 3 \text{ GHz}, Z_S = Z_{\text{Sopt}}$	$F$	-	0.9	1.4	dB
-		-	1.3	-	
Power gain, maximum stable <sup>1)</sup> $I_C = 20 \text{ mA}, V_{CE} = 2 \text{ V}, Z_S = Z_{\text{Sopt}}, Z_L = Z_{\text{Lopt}}, f = 1.8 \text{ GHz}$	$G_{ms}$	-	21.5	-	dB
Power gain, maximum available <sup>1)</sup> $I_C = 20 \text{ mA}, V_{CE} = 2 \text{ V}, Z_S = Z_{\text{Sopt}}, Z_L = Z_{\text{Lopt}}, f = 3 \text{ GHz}$	$G_{ma}$	-	16	-	dB
Transducer gain $I_C = 20 \text{ mA}, V_{CE} = 2 \text{ V}, Z_S = Z_L = 50\Omega, f = 1.8\text{GHz}$ $I_C = 20 \text{ mA}, V_{CE} = 2 \text{ V}, Z_S = Z_L = 50\Omega, f = 3\text{GHz}$	$ S_{21e} ^2$	16	18.5	-	dB
-		-	14	-	
Third order intercept point at output <sup>2)</sup> $V_{CE} = 2 \text{ V}, I_C = 20 \text{ mA}, Z_S = Z_L = 50\Omega, f = 1.8\text{GHz}$	$IP_3$	-	24.5	-	dBm
1dB Compression point at output $I_C = 20 \text{ mA}, V_{CE} = 2 \text{ V}, Z_S = Z_L = 50\Omega, f = 1.8\text{GHz}$	$P_{-1\text{dB}}$	-	11	-	

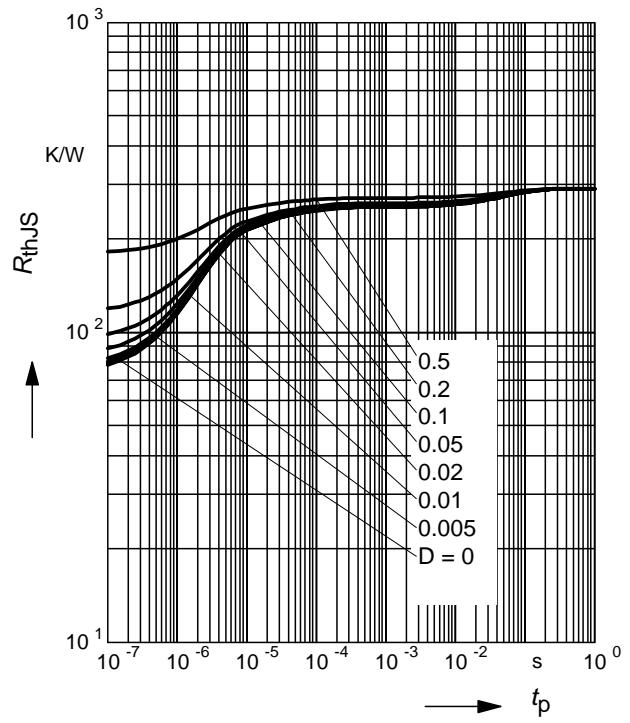
<sup>1</sup> $G_{ma} = |S_{21e} / S_{12e}| (k - (k^2 - 1)^{1/2})$ ,  $G_{ms} = |S_{21e} / S_{12e}|$ 
<sup>2</sup>IP3 value depends on termination of all intermodulation frequency components.

Termination used for this measurement is  $50\Omega$  from 0.1 MHz to 6 GHz

**Total power dissipation**  $P_{\text{tot}} = f(T_S)$

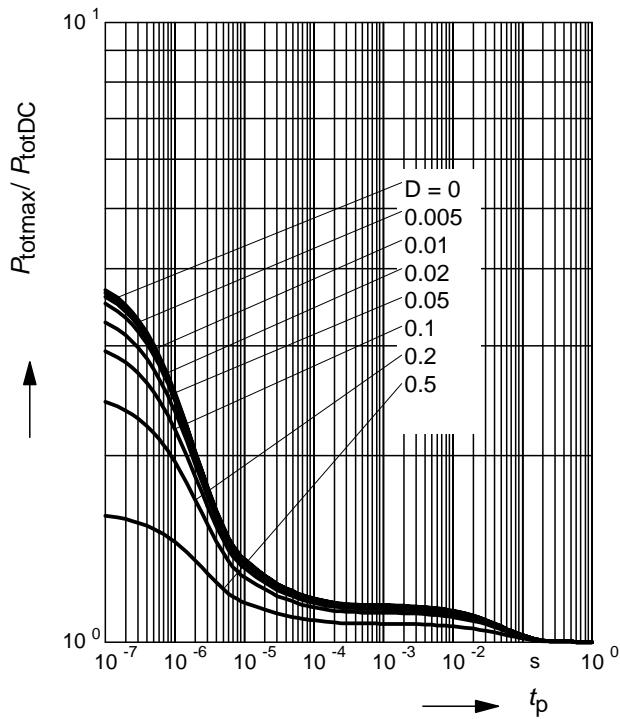


**Permissible Pulse Load**  $R_{\text{thJS}} = f(t_p)$



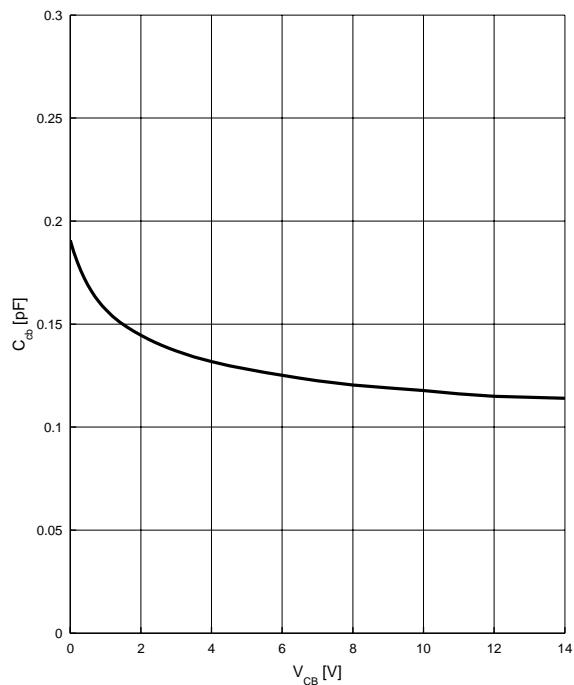
**Permissible Pulse Load**

$$P_{\text{totmax}}/P_{\text{totDC}} = f(t_p)$$



**Collector-base capacitance**  $C_{\text{cb}} = f(V_{\text{CB}})$

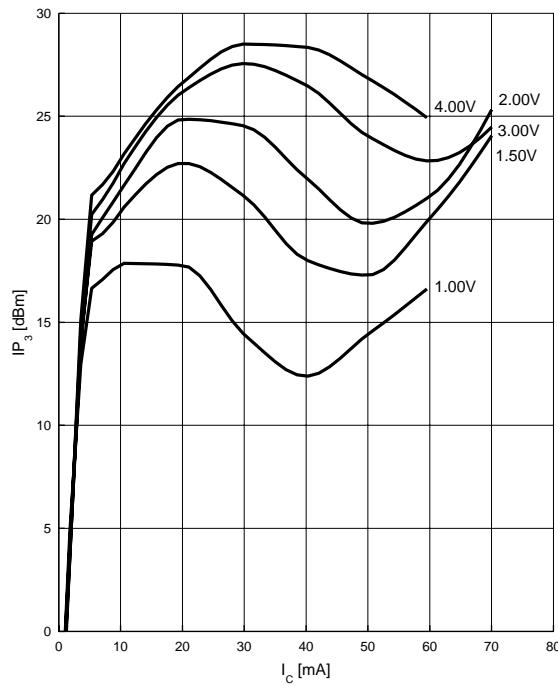
$$f = 1 \text{ MHz}$$



**Third order Intercept Point  $IP_3 = f (I_C)$**

(Output,  $Z_S = Z_L = 50 \Omega$ )

$V_{CE}$  = parameter,  $f = 900$  MHz

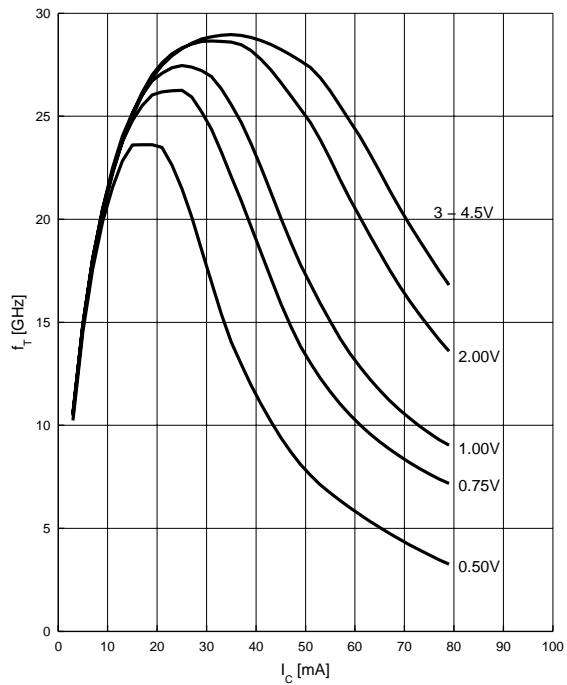


**Power gain  $G_{ma}, G_{ms} = f (f)$**

$V_{CE} = 3$  V,  $I_C = 25$  mA

**Transition frequency  $f_T = f(I_C)$**

$V_{CE}$  = parameter in V,  $f = 2$  GHz

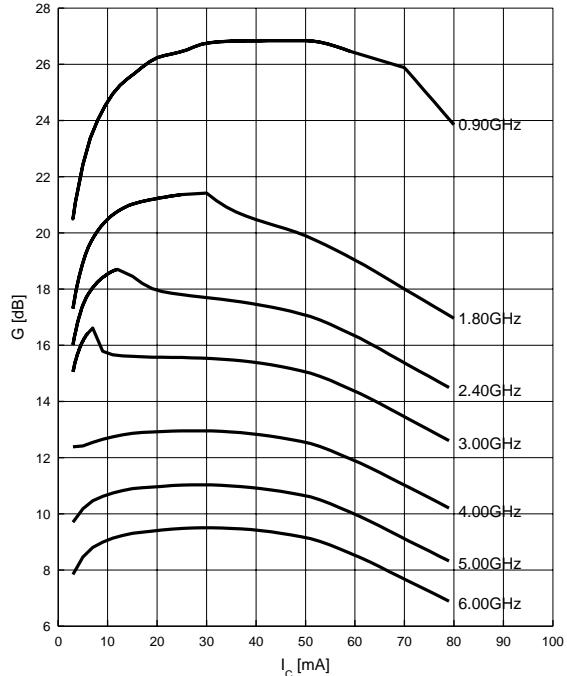
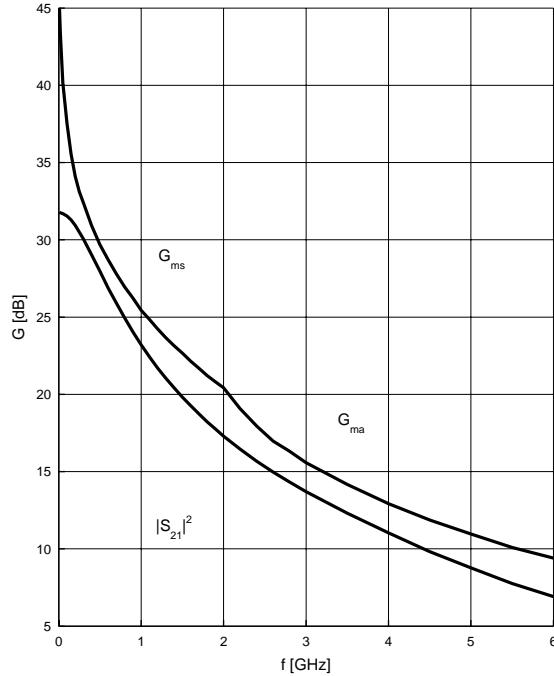


**Power gain  $G_{ma}, G_{ms} = f (I_C)$**

**Power gain  $G_{ma}, G_{ms} = f (f)$**

$V_{CE} = 3$  V

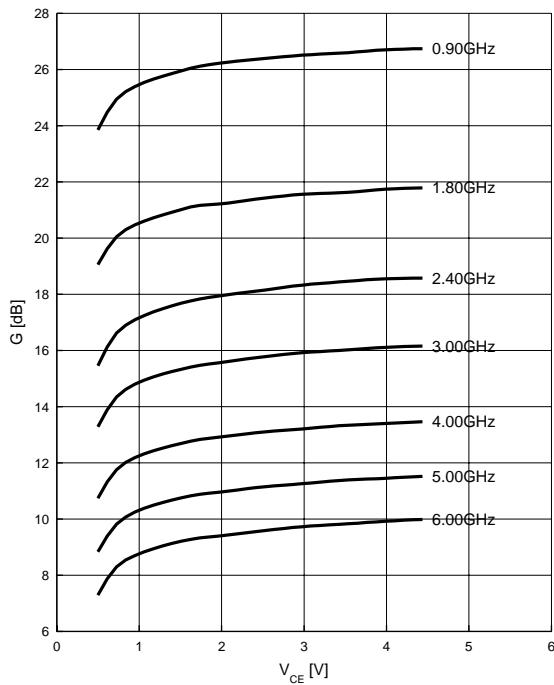
$f$  = parameter in GHz



**Power gain  $G_{\text{ma}}, G_{\text{ms}} = f(V_{\text{CE}})$**

$I_{\text{C}} = 200 \text{ mA}$

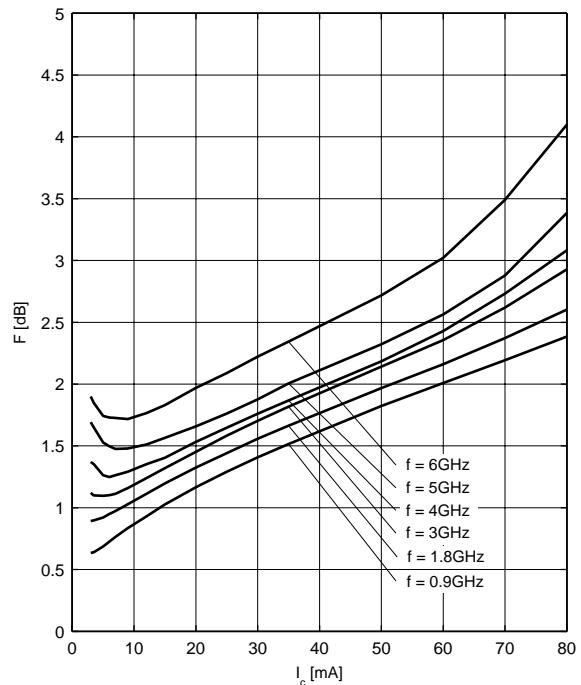
$f = \text{parameter in GHz}$



**Noise figure  $F = f(I_{\text{C}})$**

$V_{\text{CE}} = 3 \text{ V}, f = \text{parameter in GHz}$

$Z_{\text{S}} = Z_{\text{Sopt}}$

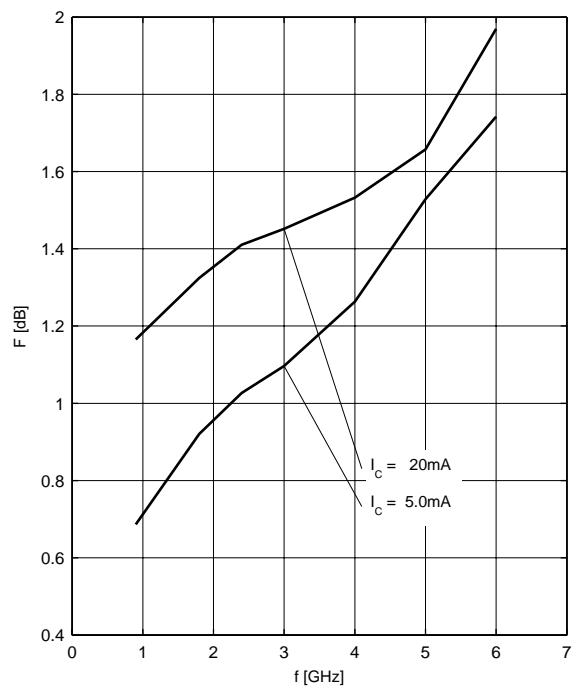
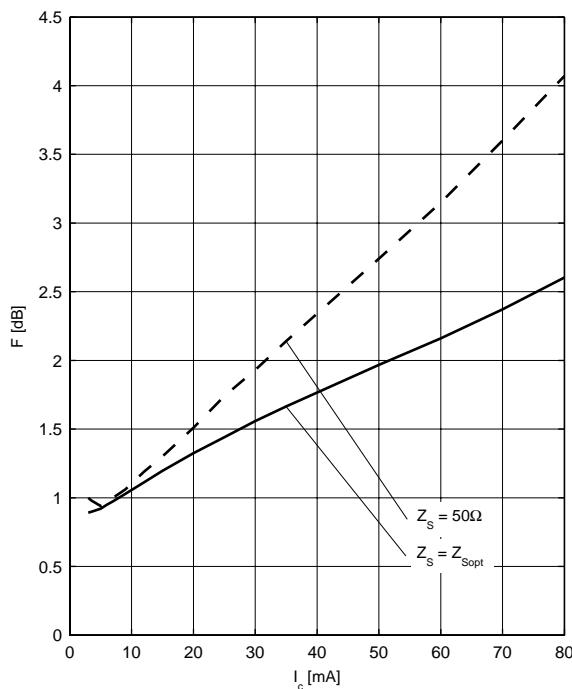


**Noise figure  $F = f(I_{\text{C}})$**

$V_{\text{CE}} = 3 \text{ V}, f = 1.8 \text{ GHz}$

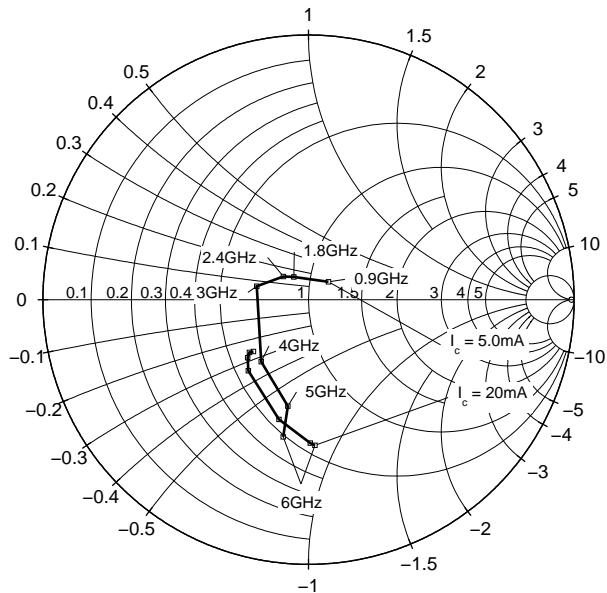
**Noise figure  $F = f(f)$**

$V_{\text{CE}} = 3 \text{ V}, Z_{\text{S}} = Z_{\text{Sopt}}$

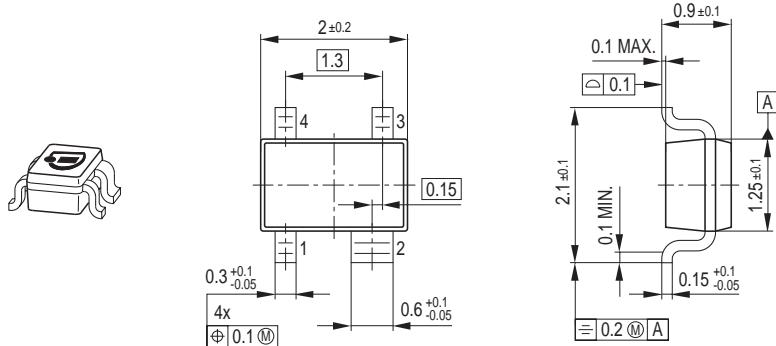


**Source impedance for min.**

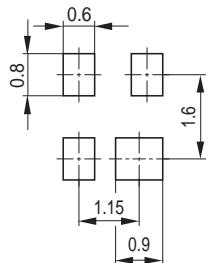
noise figure vs. frequency

 $V_{CE} = 3 \text{ V}$ ,  $I_C = 5 \text{ mA} / 20 \text{ mA}$ 


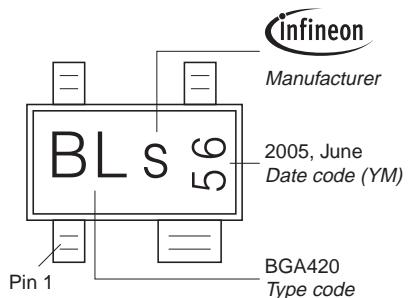
## Package Outline



## Foot Print

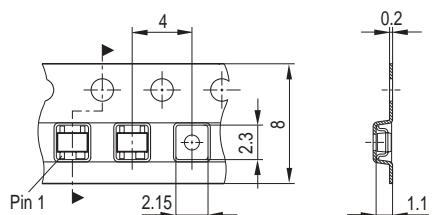


## Marking Layout (Example)



## Standard Packing

Reel ø180 mm = 3.000 Pieces/Reel  
 Reel ø330 mm = 10.000 Pieces/Reel



Edition 2006-02-01

Published by

Infineon Technologies AG

81726 München, Germany

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